UNISONIC TECHNOLOGIES CO., LTD

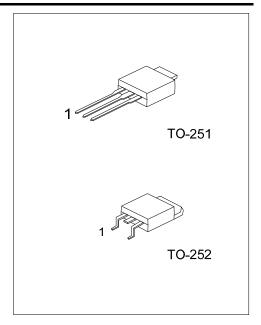
2N65-TC Power MOSFET

2A, 650V N-CHANNEL POWER MOSFET

■ DESCRIPTION

The UTC **2N65-TC** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

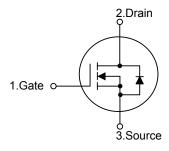
The UTC **2N65-TC** is generally applied in high efficiency switch mode power supplies.



■ FEATURES

- * $R_{DS(ON)}$ < 4.8 Ω @ V_{GS} = 10 V, I_{D} = 1.0A
- * High Switching Speed

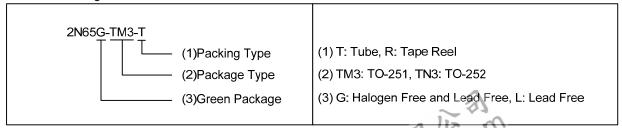
■ SYMBOL



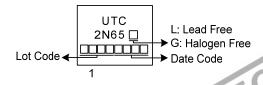
■ ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Docking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
2N65L-TM3-T	2N65G-TM3-T	TO-251	G	D	S	Tube	
2N65L-TN3-R	2N65G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	650	V	
Gate-Source Voltage		V_{GSS}	± 30	V	
Drain Current	Continuous	I_D	2	Α	
	Pulsed (Note 2)	I_{DM}	4	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	55	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.8	V/ns	
Power Dissipation		P_D	44	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 10mH, I_{AS} = 3.4A, V_{DD} = 90V, R_G = 25 Ω Starting T_J = 25°C
- 4. $I_{SD} \le 2.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	°C/W		
Junction to Case	θ_{JC}	2.87	°C/W	

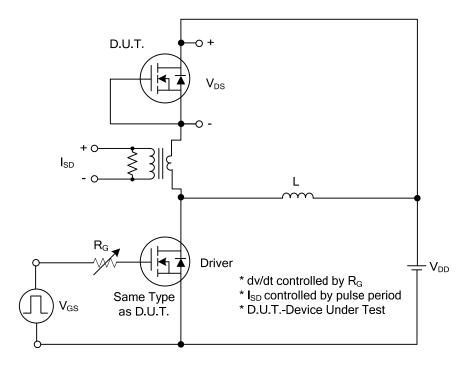
■ **ELECTRICAL CHARACTERISTICS** (T_J = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS				ā.		ā.	
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0 V , I_D = 250 μ A	650			V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =650V, V _{GS} =0V			1	μΑ
Gate-Source Leakage Current	Forward	1	V _{GS} =30V, V _{DS} =0V			100	nA
	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =1.0A			4.8	Ω
DYNAMIC CHARACTERISTICS				ā.		ā.	
Input Capacitance	Input Capacitance				301		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0 MHz		38		pF
Reverse Transfer Capacitance		C _{RSS}			2.5		pF
SWITCHING CHARACTERISTICS	S			ā.		ā.	
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A		10.8		nC
Gateource Charge		Q_{GS}	I _G =100µA (Note 1, 2)		2.2		nC
Gate-Drain Charge		Q_GD	IG-100μA (Note 1, 2)		2.1		nC
Turn-on Delay Time (Note 1)		$t_{D(ON)}$			28		ns
Rise Time		t_R	V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A, R_{G} =25 Ω (Note 1, 2)		23		ns
Turn-off Delay Time		$t_{D(OFF)}$			62		ns
Fall-Time		t_{F}			19		ns
SOURCE- DRAIN DIODE RATING	SS AND CH	ARACTERIST	TICS				
Maximum Body-Diode Continuous Current		Is	2 112 5			2	Α
Maximum Body-Diode Pulsed Current		I _{SM}	SE CO'	*		8	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	V _{GS} =0V, I _S =2.0A			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	V _{GS} =0V, I _S =2.0A,		205		ns
Reverse Recovery Charge		Q_{rr}	dl _F /dt=100A/µs (Note1)		1.2		μC

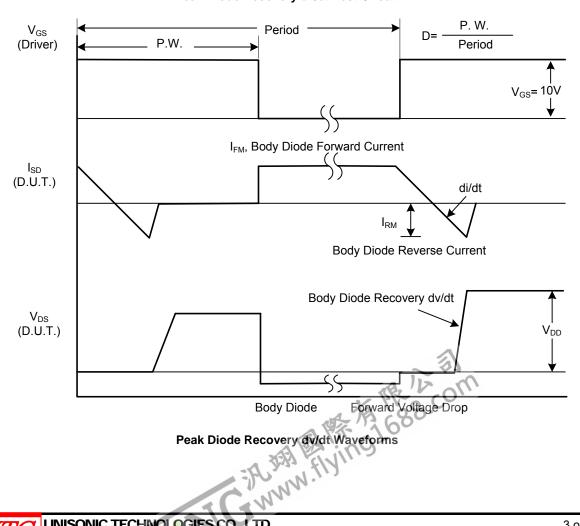
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

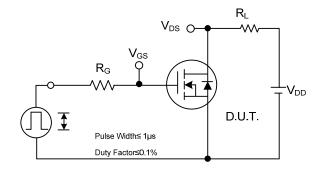


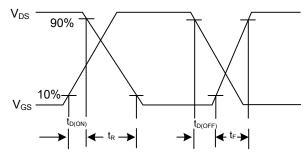
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

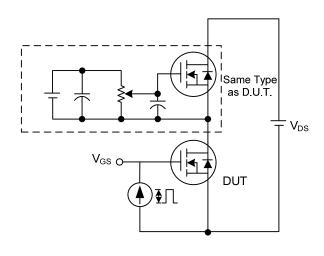
TEST CIRCUITS AND WAVEFORMS

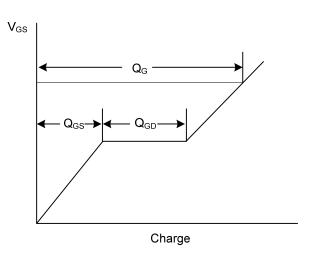




Switching Test Circuit

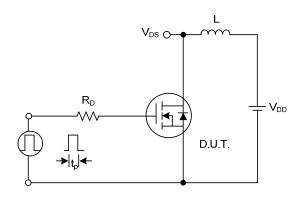
Switching Waveforms

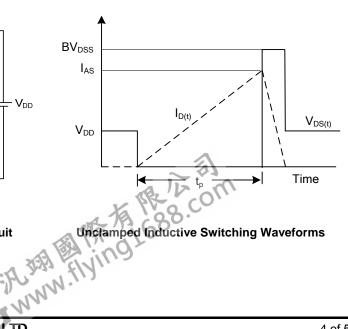




Gate Charge Test Circuit

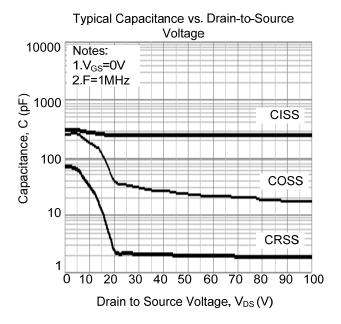
Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

■ TYPICAL CHARACTERISTICS



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